

N-channel 650 V, 0.275 Ω typ., 12 A MDmesh™ M2 Power MOSFET in a TO-220FP ultra narrow leads package

Datasheet - production data

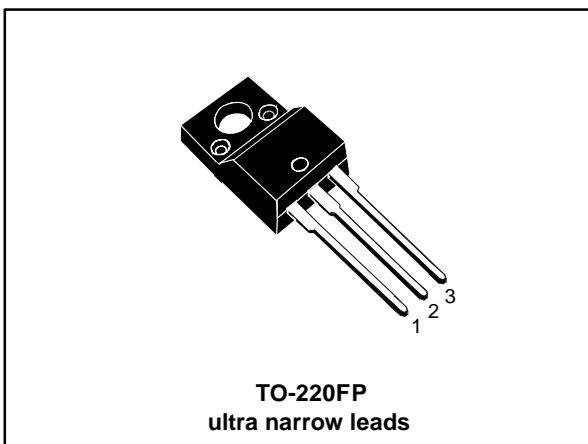
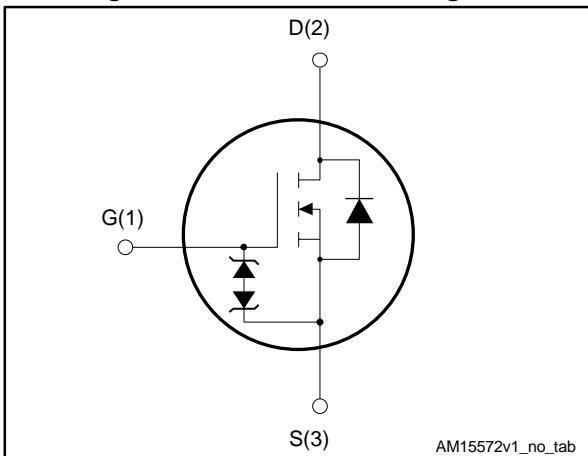


Figure 1: Internal schematic diagram



Features

| Order code | V _{DS} | R _{D(on)} max | I _D |
|-------------|-----------------|------------------------|----------------|
| STFU18N65M2 | 650 V | 0.33 Ω | 12 A |

- Extremely low gate charge
- Excellent output capacitance (C_{oss}) profile
- 100% avalanche tested
- Zener-protected

Applications

- Switching applications
- LLC converters, resonant converters

Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

Table 1: Device summary

| Order code | Marking | Package | Packaging |
|-------------|---------|--------------------------------|-----------|
| STFU18N65M2 | 18N65M2 | TO-220FP ultra narrow leads | Tube |

Contents

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1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|------------------------|---|-------------------|------------|
| V_{GS} | Gate-source voltage | ± 25 | V |
| I_D | Drain current (continuous) at $T_C = 25^\circ C$ | 12 ⁽¹⁾ | A |
| I_D | Drain current (continuous) at $T_C = 100^\circ C$ | 8 ⁽¹⁾ | A |
| $I_{DM}^{(2)}$ | Drain current (pulsed) | 48 ⁽¹⁾ | A |
| P_{TOT} | Total dissipation at $T_C = 25^\circ C$ | 25 | W |
| V_{ISO} | Insulation withstand voltage (RMS) from all three leads to external heat sink ($t = 1$ s; $T_C = 25^\circ C$) | 2500 | V |
| dv/dt ⁽³⁾ | Peak diode recovery voltage slope | 15 | V/ns |
| dv/dt ⁽⁴⁾ | MOSFET dv/dt ruggedness | 50 | |
| T_{stg} | Storage temperature | - 55 to 150 | $^\circ C$ |
| T_j | Max. operating junction temperature | | |

Notes:

(1)Limited by maximum junction temperature.

(2)Pulse width limited by safe operating area.

(3) $I_{SD} \leq 10$ A, $dI/dt \leq 400$ A/ μ s; $V_{DSpeak} < V_{(BR)DSS}$, $V_{DD} = 400$ V(4) $V_{DS} \leq 520$ V

Table 3: Thermal data

| Symbol | Parameter | Value | Unit |
|----------------|---|-------|--------------|
| $R_{thj-case}$ | Thermal resistance junction-case max | 5 | $^\circ C/W$ |
| $R_{thj-amb}$ | Thermal resistance junction-ambient max | 62.5 | $^\circ C/W$ |

Table 4: Avalanche characteristics

| Symbol | Parameter | Value | Unit |
|----------|--|-------|------|
| I_{AR} | Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax}) | 2 | A |
| E_{AS} | Single pulse avalanche energy (starting $T_j = 25^\circ C$, $I_D = I_{AR}$; $V_{DD} = 50$ V) | 450 | mJ |

2 Electrical characteristics

($T_C = 25^\circ\text{C}$ unless otherwise specified)

Table 5: On /off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------|--|---|------|-------|----------|---------------|
| $V_{(\text{BR})\text{DSS}}$ | Drain-source breakdown voltage | $I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$ | 650 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = 650 \text{ V}$ | | | 1 | μA |
| | | $V_{DS} = 650 \text{ V}, T_C = 125^\circ\text{C}$ | | | 100 | μA |
| I_{GS} | Gate-body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 25 \text{ V}$ | | | ± 10 | μA |
| $V_{GS(\text{th})}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ | 2 | 3 | 4 | V |
| $R_{DS(\text{on})}$ | Static drain-source on-resistance | $V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$ | | 0.275 | 0.33 | Ω |

Table 6: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------------|-------------------------------|--|------|------|------|----------|
| C_{iss} | Input capacitance | | - | 770 | - | pF |
| C_{oss} | Output capacitance | $V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$ | - | 35 | - | pF |
| C_{rss} | Reverse transfer capacitance | | - | 1.2 | - | pF |
| $C_{oss \text{ eq. } (1)}$ | Equivalent output capacitance | $V_{DS} = 0 \text{ to } 520 \text{ V}, V_{GS} = 0 \text{ V}$ | - | 175 | - | pF |
| R_G | Intrinsic gate resistance | $f = 1 \text{ MHz}, I_D = 0$ | - | 6.1 | - | Ω |
| Q_g | Total gate charge | $V_{DD} = 520 \text{ V}, I_D = 12 \text{ A}, V_{GS} = 10 \text{ V}$ (see Figure 15: "Test circuit for gate charge behavior") | - | 20 | - | nC |
| Q_{gs} | Gate-source charge | | - | 3.6 | - | nC |
| Q_{gd} | Gate-drain charge | | - | 8.5 | - | nC |

Notes:

⁽¹⁾ $C_{oss \text{ eq.}}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Table 7: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 325 \text{ V}, I_D = 6 \text{ A}, R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 14: "Test circuit for resistive load switching times" and Figure 19: "Switching time waveform") | - | 11 | - | ns |
| t_r | Rise time | | - | 7.5 | - | ns |
| $t_{d(off)}$ | Turn-off delay time | | - | 46 | - | ns |
| t_f | Fall time | | - | 12.5 | - | ns |

Table 8: Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|---|------|------|------|---------------|
| I_{SD} | Source-drain current | | - | | 12 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 48 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 12 \text{ A}, V_{GS} = 0 \text{ V}$ | - | | 1.6 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 12 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 60 \text{ V}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i>) | - | 331 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 3.4 | | μC |
| I_{RRM} | Reverse recovery current | | - | 20.5 | | A |
| t_{rr} | Reverse recovery time | $I_{SD} = 12 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 60 \text{ V}, T_j = 150 \text{ }^\circ\text{C}$, (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i>) | - | 462 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 4.6 | | μC |
| I_{RRM} | Reverse recovery current | | - | 20 | | A |

Notes:

(1)Pulse width limited by safe operating area.

(2)Pulsed: pulse duration = 300 μs , duty cycle 1.5%.

2.1 Electrical characteristics (curves)

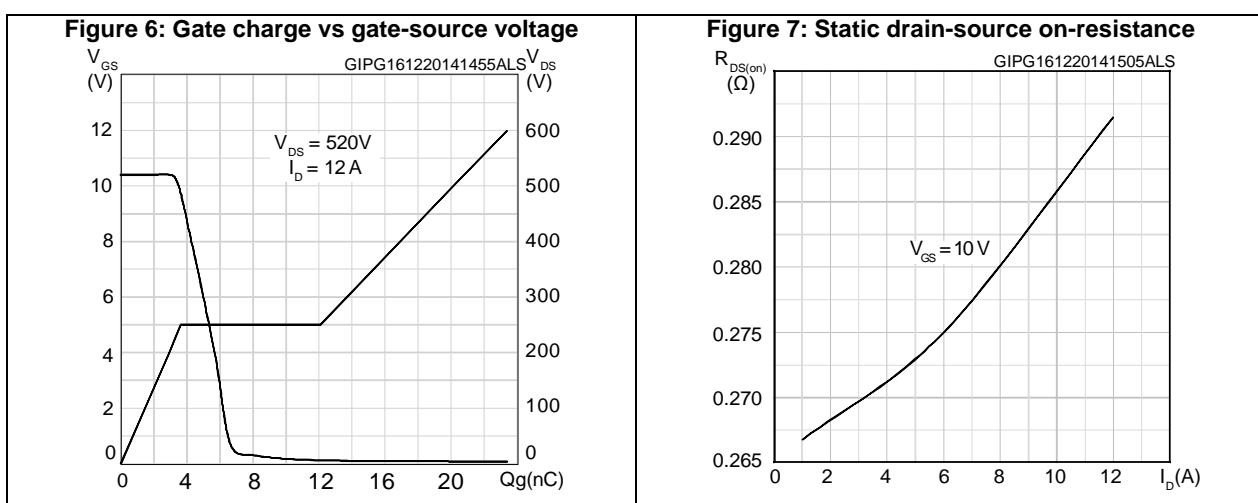
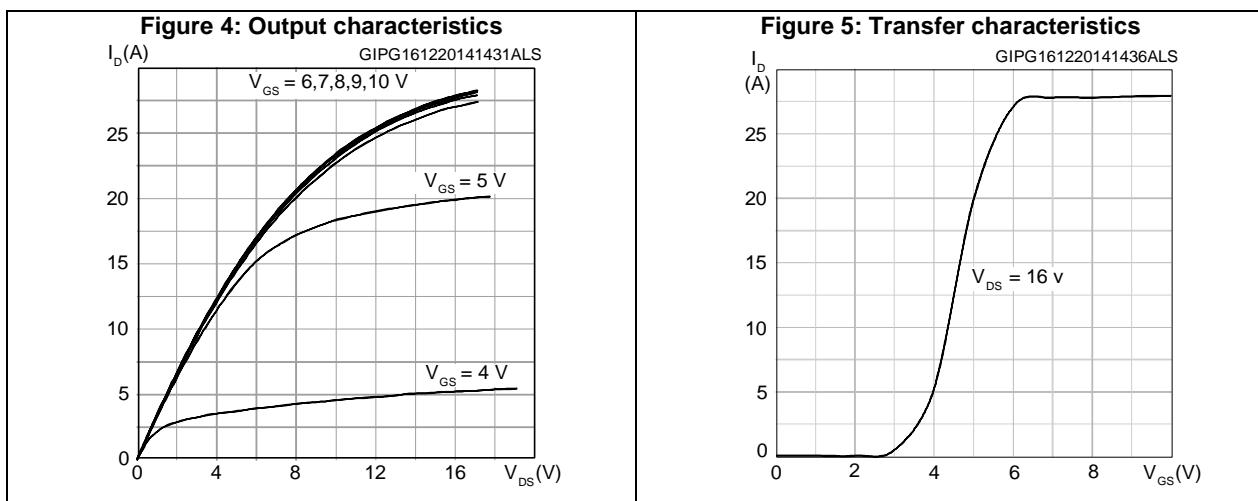
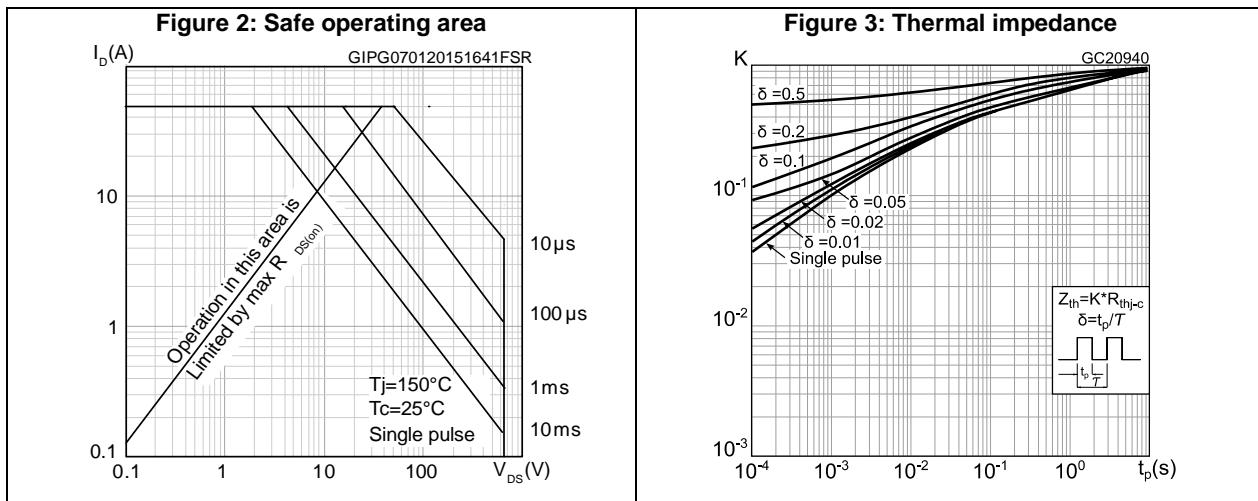
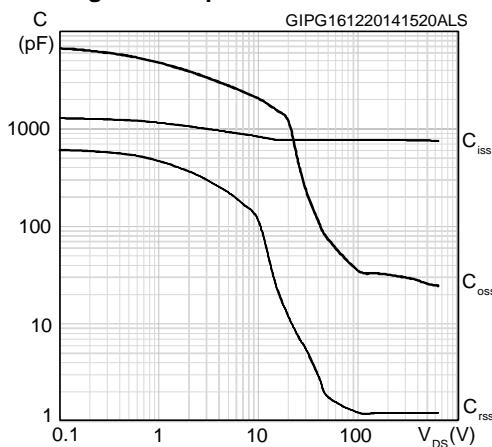
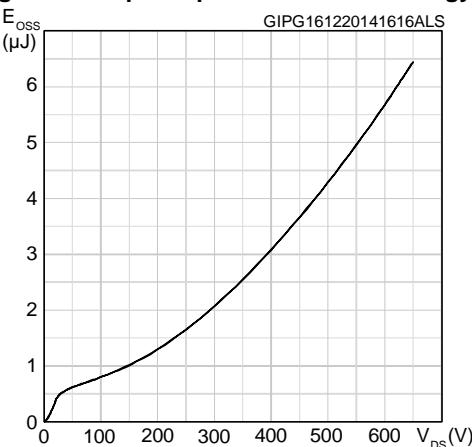
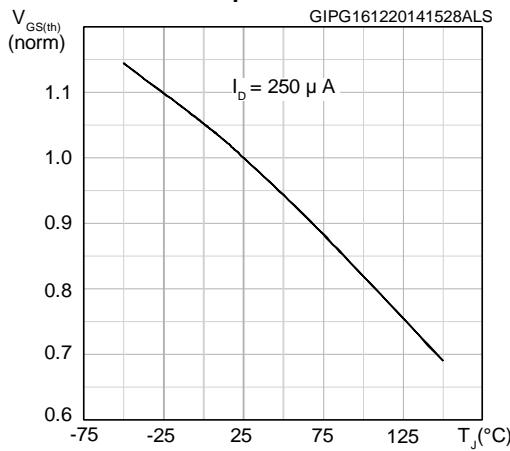
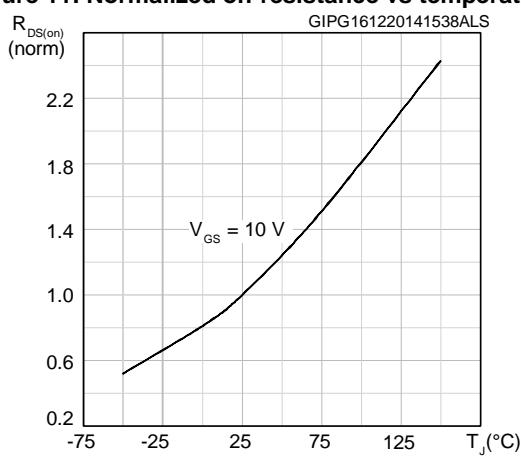
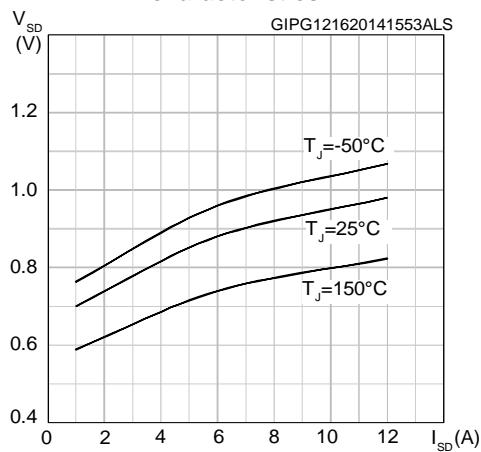
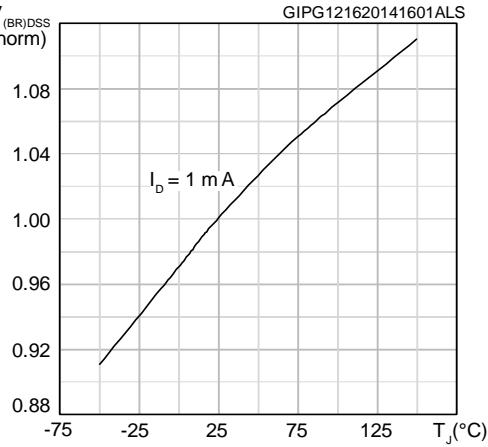


Figure 8: Capacitance variations**Figure 9: Output capacitance stored energy****Figure 10: Normalized gate threshold voltage vs temperature****Figure 11: Normalized on-resistance vs temperature****Figure 12: Source-drain diode forward characteristics****Figure 13: Normalized V(BR)DSS vs temperature**

3 Test circuit

Figure 14: Test circuit for resistive load switching times

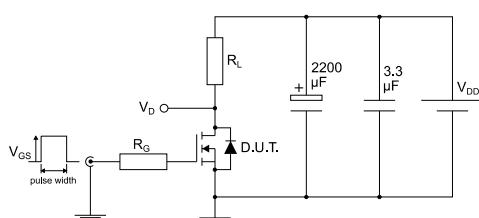


Figure 15: Test circuit for gate charge behavior

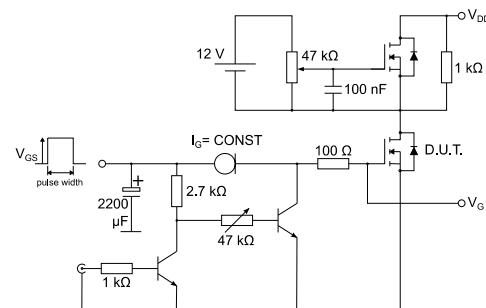


Figure 16: Test circuit for inductive load switching and diode recovery times

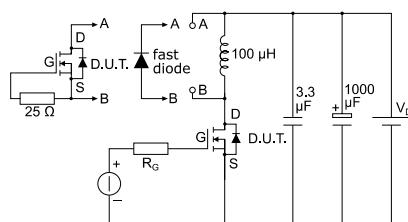


Figure 17: Unclamped inductive load test circuit

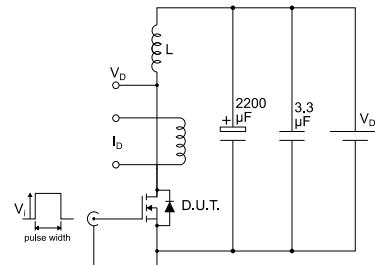


Figure 18: Unclamped inductive waveform

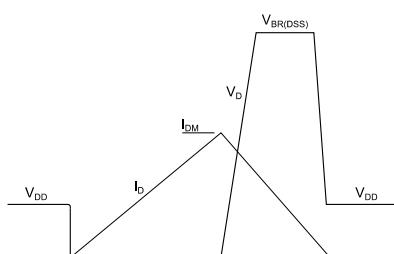
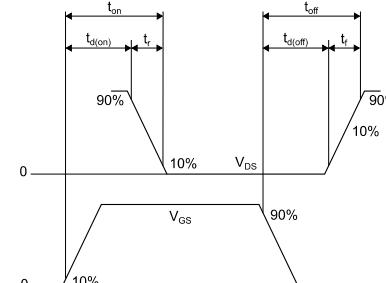


Figure 19: Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.
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4.1 TO-220FP unl package information

Figure 20: TO-220FP ultra narrow leads package outline

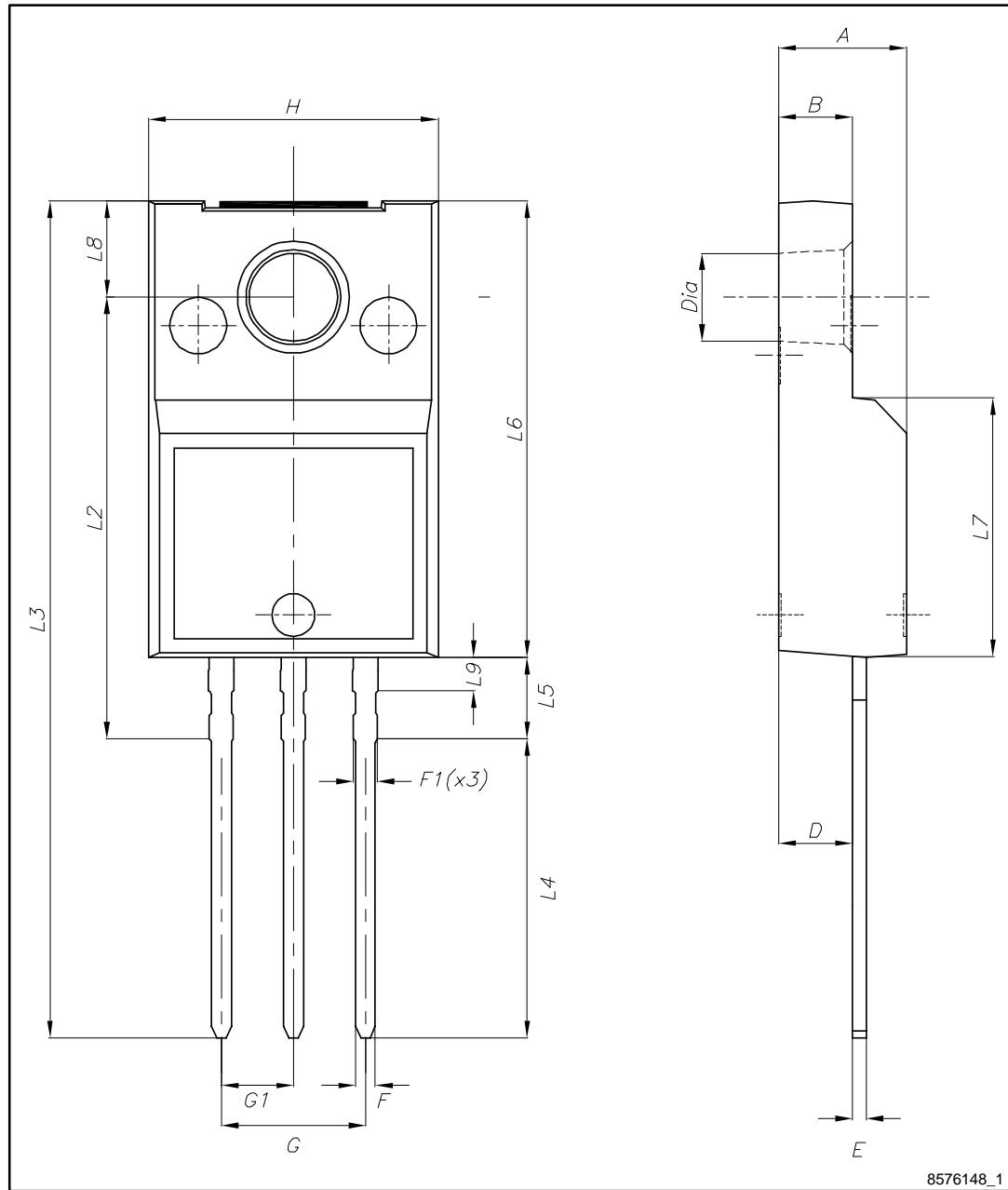


Table 9: TO-220FP ultra narrow leads mechanical data

| Dim. | mm | | |
|------|-------|------|-------|
| | Min. | Typ. | Max. |
| A | 4.40 | | 4.60 |
| B | 2.50 | | 2.70 |
| D | 2.50 | | 2.75 |
| E | 0.45 | | 0.60 |
| F | 0.65 | | 0.75 |
| F1 | - | | 0.90 |
| G | 4.95 | | 5.20 |
| G1 | 2.40 | 2.54 | 2.70 |
| H | 10.00 | | 10.40 |
| L2 | 15.10 | | 15.90 |
| L3 | 28.50 | | 30.50 |
| L4 | 10.20 | | 11.00 |
| L5 | 2.50 | | 3.10 |
| L6 | 15.60 | | 16.40 |
| L7 | 9.00 | | 9.30 |
| L8 | 3.20 | | 3.60 |
| L9 | - | | 1.30 |
| Dia. | 3.00 | | 3.20 |

5 Revision history

Table 10: Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 05-Mar-2015 | 1 | Initial release |
| 07-Oct-2015 | 2 | Document status promoted from preliminary to production data. |

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